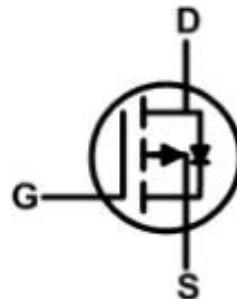
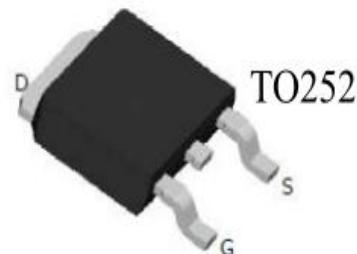


100V P-Channel Fast Switching MOSFET

■ Features

- $V_{DSS} = -100V$ $I_D = -4.1A$
- $R_{DS(ON)} = 0.65\Omega$ (max.)@ $V_{GS} = -10V$
- $R_{DS(ON)} = 0.7\Omega$ (max.)@ $V_{GS} = -4.5V$
- Excellent CdV/dt effect decline
- Super Low Gate Charge
- 100% EAS Guaranteed
- Green Device Available
- Advanced high cell density Trench technology

■ PIN DESCRIPTION



■ Applications

- The SI0107D is the high cell density trenched P-ch MOSFETS, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.
- The SI0107D meet the ROHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Part Number	Package	Marking	ROHS Status	Packing
SI0107D	TO-252	D0107	Halogen-Free	Tape&Reel

■ Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V_{DS}	Drain-Source Voltage	-100	V	
V_{GS}	Gate-Source Voltage	± 20	V	
I_D	Continuous Drain Current, $V_{GS} = -10V$	$T_c = 25^\circ C$	-4.1	A
		$T_c = 100^\circ C$	-2.6	A
I_D	Continuous Drain Current, $V_{GS} = -10V$	$T_A = 25^\circ C$	-1.3	A
		$T_A = 70^\circ C$	-1	A
I_{DM}	Pulsed Drain Current	-8.2	A	
T_J, T_{stg}	Operating Junction and Storage Temperature Range	-55 to 150	°C	
P_D	Total Power Dissipation	$T_c = 25^\circ C$	20.8	W
		$T_A = 25^\circ C$	2	W

■ THERMAL RESISTANCE RATINGS

Symbol	Parameter	Typical	Max	Unit
$R_{\theta JA}$	Maximum Junction-to-Ambient	-	62	°C/W
$R_{\theta JC}$	Maximum Junction-to-Case	-	6	

Electrical Characteristics (T_J=25°C unless otherwise Ratings)

Symbol	Parameter	Test Conditions	Min.	TYP.	Max.	Unit
Static Characteristics						
B _{VDSS}	Drain-source breakdown voltage	V _{GS} =0V, I _{DS} =-250uA	-100	-	-	V
V _{GS(th)}	Gate threshold voltage	V _{DS} =V _{GS} , I _{DS} =-250uA	-1.0	-	-2.5	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-80V, V _{GS} =0V, T _j =25°C	-	-	-10	uA
		V _{DS} =-80V, V _{GS} =0V, T _j =55°C	-	-	-100	uA
I _{GSS}	Gate-source leakage current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(on)}	Drain-source on-state resistance	V _{GS} =-10V, I _D =-1A	-	-	0.65	Ω
		V _{GS} = -4.5V, I _D =-0.5A	-	-	0.7	Ω
G _{fs}	Forward Transconductance	V _{DS} =-5V , I _D =-1A	-	3	-	S
R _g	Gate Resistance	V _{DS} =0V, V _{GS} =0V , f=1MHz	-	-	32	Ω
Dynamic Characteristic						
Q _g	Total Gate Charge	V _{GS} =-4.5V, V _{DS} =-15V I _{DS} =-1A	-	4.5	-	nC
Q _{gs}	Gate-Source Charge		-	1.14	-	nC
Q _{gd}	Gate-Drain Charge		-	1.5	-	nC
T _{d(on)}	Turn-on delay time	I _D =-1A, V _{GS} =-10V V _{DD} =-50V, R _G =3.3Ω	-	13.6	-	nS
T _r	Rise time		-	6.8	-	nS
T _{d(off)}	Turn-off delay time		-	34	-	nS
T _f	Fall time		-	3	-	nS
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V f=1.0MHz	-	553	-	pF
C _{oss}	Output Capacitance		-	29	-	pF
C _{rss}	Reverse Transfer Capacitance		-	20	-	pF
Source-Drain Diode						
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =-1A	-	-	-1.2	V
I _{SM}	Pulsed Source Current	V _G =V _D =0V Force Current	-	-	-8.2	A
I _S	Continuous Source Current		-	-	-4.1	A

Notes:

1. The data tested by surface mounted on a 1 inch ² FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width ≤300us , duty cycle ≤2%
- 3.The power dissipation is limited by 150 °C junction temperature
- 4.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Performance Characteristics

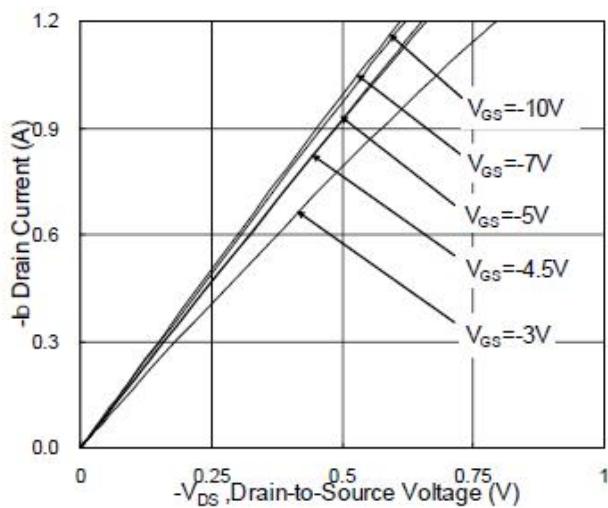


Fig.1 Typical Output Characteristics

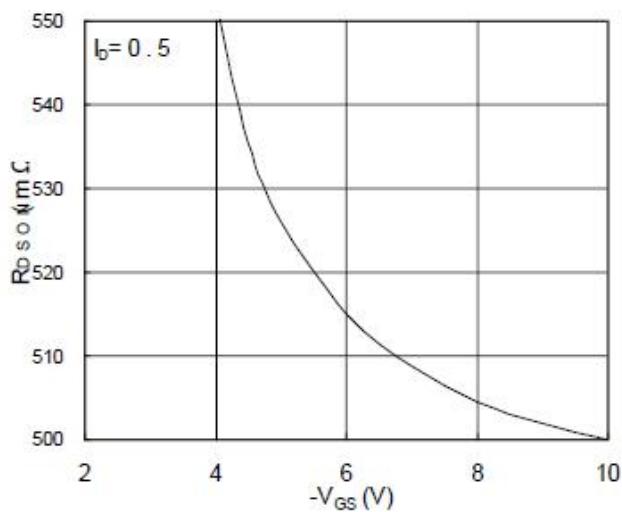


Fig.2 On-Resistance vs. Gate-Source

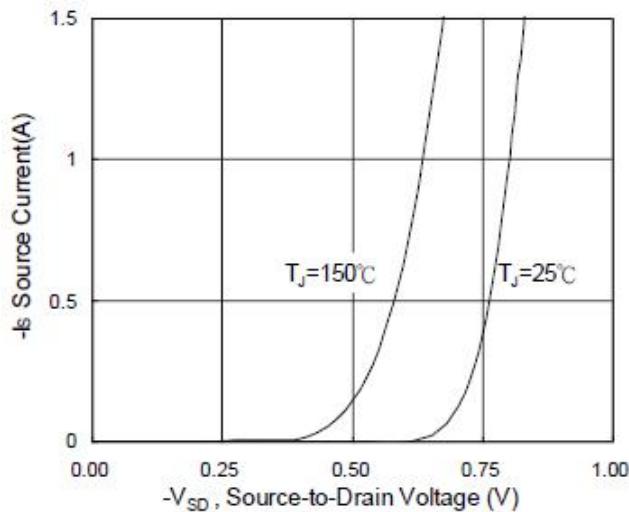


Fig.3 Forward Characteristics Of Reverse

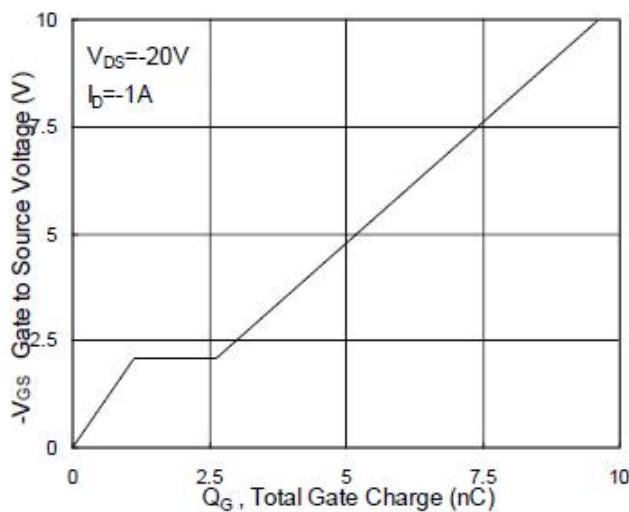


Fig.4 Gate-Charge Characteristics

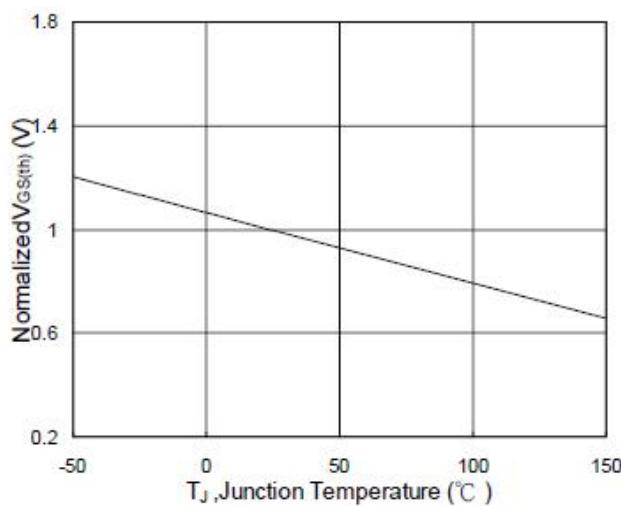


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

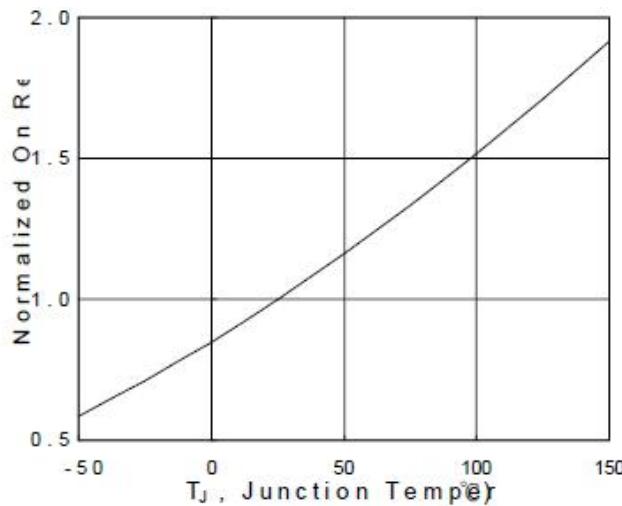
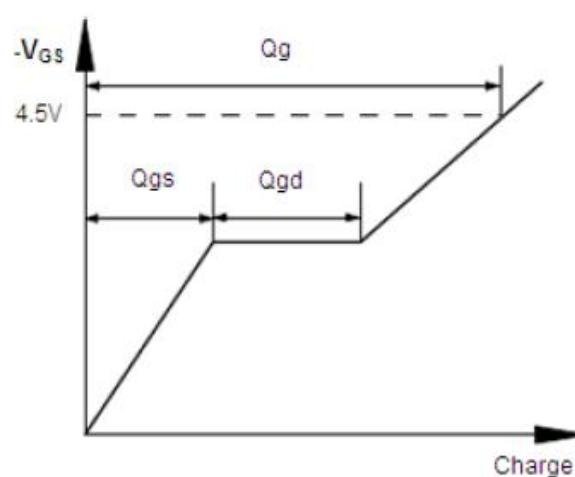
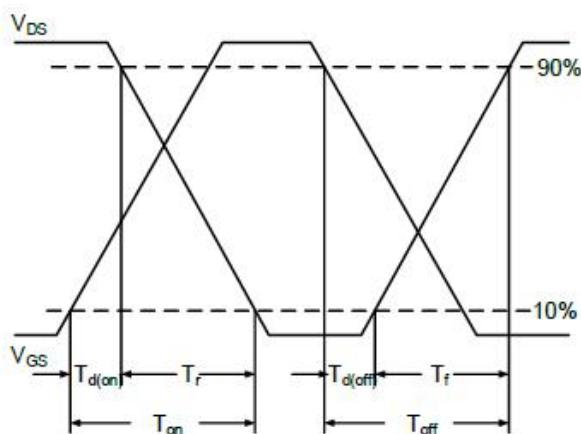
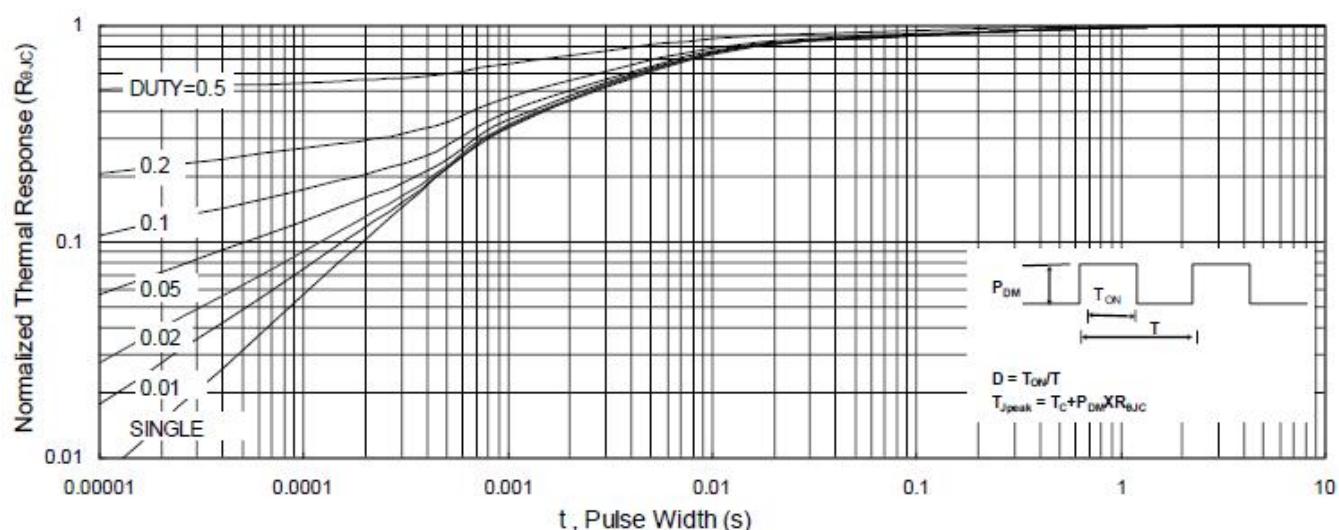
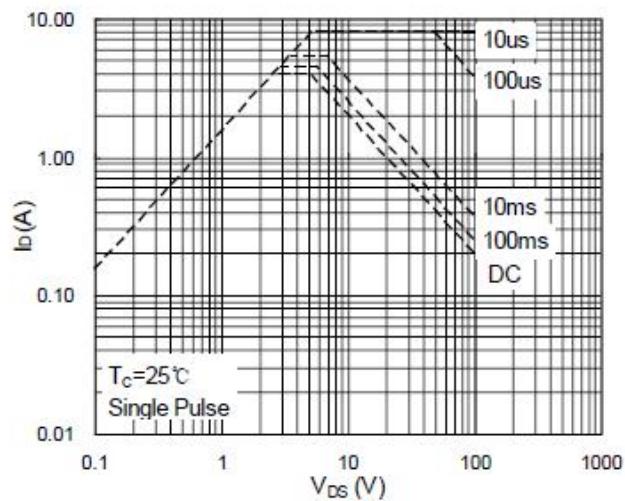
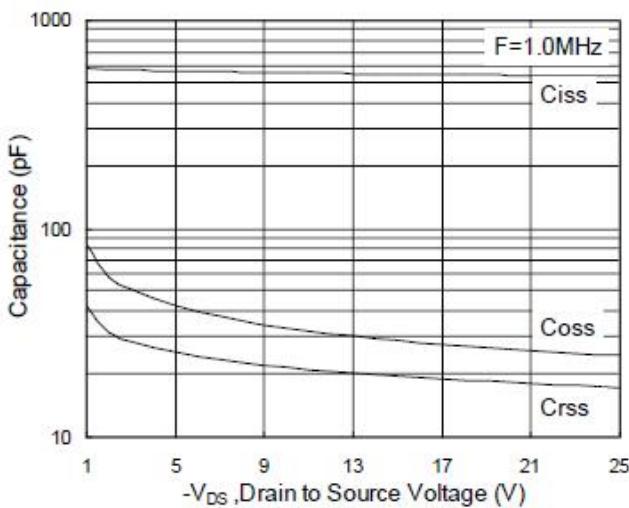


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

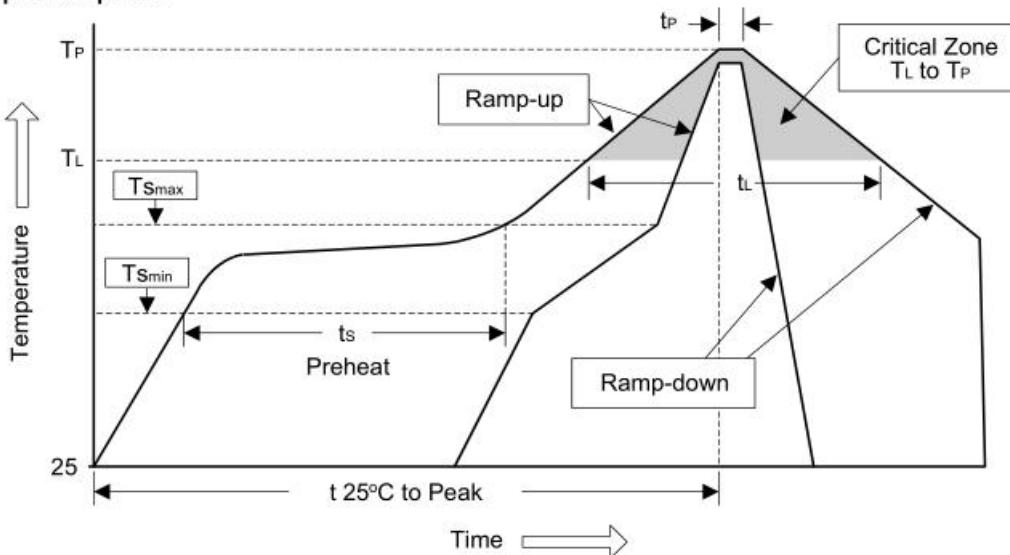
Typical Performance Characteristics (Cont.)



Soldering Methods for Products

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate(TL to TP)	<3°C/sec	<3°C/sec
Preheat	-	-
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(min to max)(ts)	60 to 120 sec	60 to 180 sec
Ts max to TL	<3°C/sec	<3°C/sec
- ramp-up rate		
Time maintained above:		
-Temperature(TL)	183°C	217°C
-Time(TL)	60 to 150 sec	60 to 150 sec
Peak Temperature(TP)	240°C+0/-5°C	250°C+0/-5°C
Time within 5°C of actual Peak Temperature	10 to 30 sec	20 to 40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25 °C to Peak Temperature	<6 minutes	<8 minutes

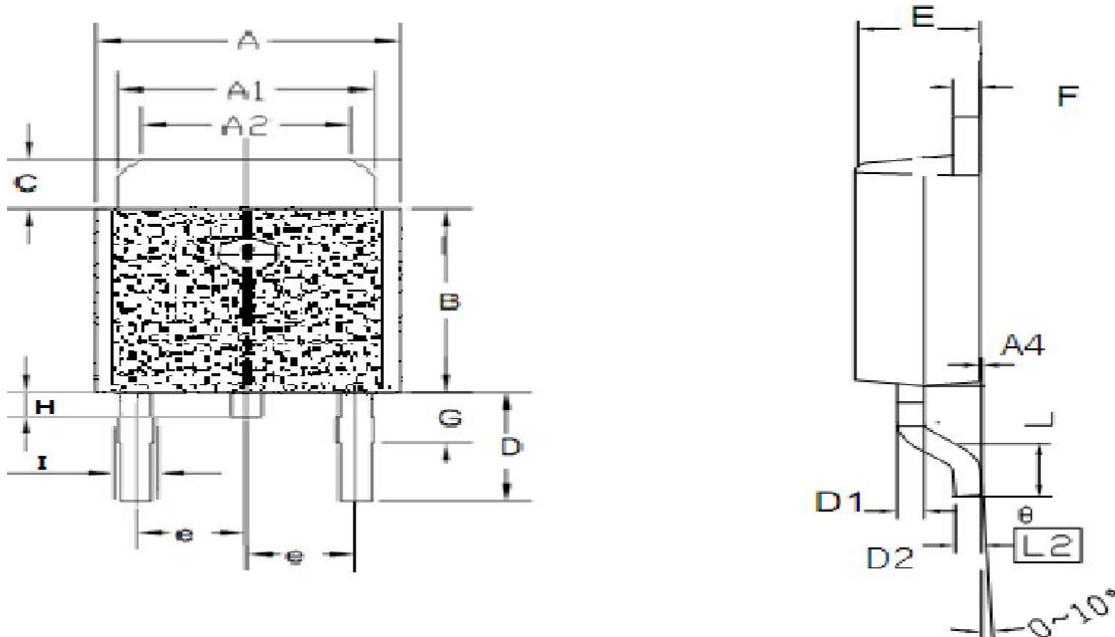
Figure 1: Temperature profile



- Note :**
- 1.Storage environment: Temperature=10°C to 35@Humidity=45%±15%
 - 2.Reflow soldering of surface-mount devices
 - 3.Flow(wave) soldering(solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices	245°C±5°C	5sec±1sec
Pb-free devices	250°C+0/-5°C	5sec±1sec

Package Outline



unit: mm					
Symbol	Min	Max	Symbol	Min	Max
A	6.40	6.60	D	2.90	3.10
A1	5.20	5.40	D1	0.45	0.55
A2	4.40	4.60	D2	0.45	0.55
A3	4.40	4.60	e	2.3BSC	
A4	0.00	0.15	E	2.20	2.40
A5	4.65	4.95	F	0.49	0.59
B	6.00	6.20	G	1.7BSC	
B1	1.57	1.77	L	1.40	1.60
C	0.90	0.96	H (度)	0.00	10.00
I	0.80	0.85		0.49	0.52

■ Important Notice

Si-Trend reserves the right to change all product、product specifications and data without prior notice ; Our customer Please confirm to place an order confirmation before make the integrity of information complete and up-to-date 。

Any semiconductor under specific conditions are possible to certain failure or malfunction rate ; Customers are responsible in the use of Si-Trend products to system design and manufacturing in compliance with safety standards and adopting safety measures , To avoid the potential risk of failure may cause the personal safety and property loss 。

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■ Modify record

Date	Version	Description	Pagination
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